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Serial No. 10/729378  
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**INFORMATION DISCLOSURE STATEMENT**  
(Use several sheets if necessary)

Applicants  
Herbert BOEGGE et al.

Filing Date  
December 8, 2003

Group Art Unit  
Not Yet Assigned 36168

**U.S. PATENT DOCUMENTS**

Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date (if appropriate)
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ED	AB	4,966,388	10-1990	Warner et al.			
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		Document	Date	Country	Class	Sub-class	Translation Yes   No
ED	AK	DE 20012116 U1	10-2000	Germany			X
ED	AL	DE 4231522 A1	03-1994	Germany			Abstract
ED	AM	WO 01/54953 A1	08-2001	WIPO			
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**OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)**

	AR	
	AS	
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Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in and not considered. Include copy of this form with next communication.

<b>Notice of References Cited</b>	Application/Control No. 10/729,378		Applicant(s)/Patent Under Reexamination BOEGGE ET AL.	
	Examiner Tiffany Webb		Art Unit 3616	Page 1 of 1

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	B	US-5,324,072	06-1994	Olson et al.	280/730.2
	C	US-5,524,924	06-1996	Steffens et al.	280/730.2
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**NON-PATENT DOCUMENTS**

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	Examiner Tiffany L. Webb	Art Unit 3616	Page 1 of 1

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	K	US-			
	L	US-			
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